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Wide Temperature Range Version 8 M SRAM (512-kword × 16-bit)



ADE-203-1280B (Z) Rev. 1.0 Mar. 15, 2002

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Description

The Hitachi HM62V16514I Series is 8-Mbit static RAM organized 524,288-word \times 16-bit. HM62V16514I Series has realized higher density, higher performance and low power consumption by employing Hi-CMOS process technology. It offers low power standby power dissipation; therefore, it is suitable for battery backup systems. It is packaged in standard 44-pin plastic TSOPII.

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- Single 3.0 V supply: 2.7 V to 3.6 V
- Fast access time: 55 ns (Max)
 - Power dissipation:
 - Active: 6.0 mW/MHz (Typ)
 - Standby: 1.5 µW (Typ)
- Completely static memory.
 - No clock or timing strobe required
- Equal access and cycle times
- Common data input and output.
 - Three state output
- Battery backup operation.
- Temperature range: -40 to +85°C

Ordering Information

Туре No.	Access time	Package
HM62V16514LTTI-5	55 ns	400-mil 44-pin plastic TSOPII (normal-bend type) (TTP-44DE)
HM62V16514LTTI-5SL	55 ns	

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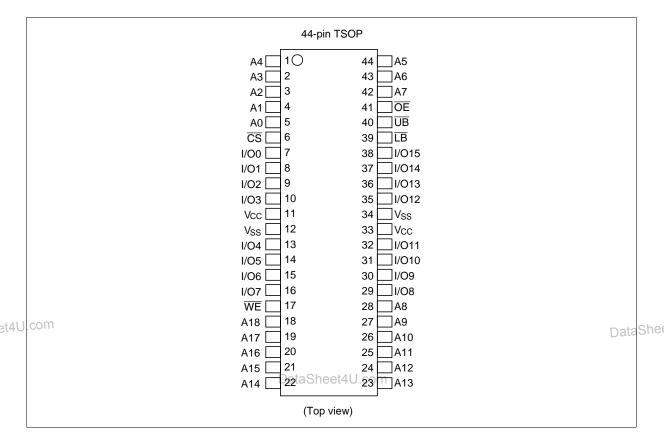
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Pin Arrangement



Pin Description

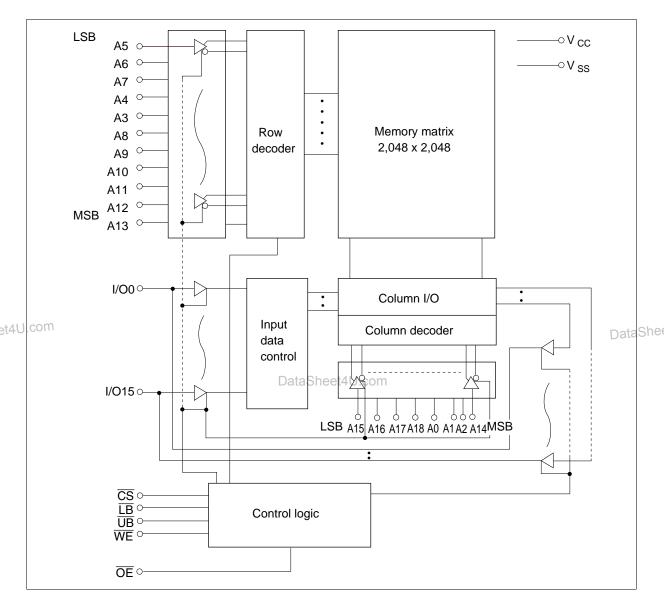
Pin name	Function
A0 to A18	Address input
I/O0 to I/O15	Data input/output
CS	Chip select
WE	Write enable
ŌĒ	Output enable
LB	Lower byte select
UB	Upper byte select
V _{cc}	Power supply
V _{SS}	Ground

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Block Diagram



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CS	WE	OE	UB	LB	I/O0 to I/O7	I/O8 to I/O15	Operation
Н	×	×	×	×	High-Z	High-Z	Standby
×	×	×	Н	Н	High-Z	High-Z	Standby
L	Н	L	L	L	Dout	Dout	Read
L	Н	L	Н	L	Dout	High-Z	Lower byte read
L	Н	L	L	Н	High-Z	Dout	Upper byte read
L	L	×	L	L	Din	Din	Write
L	L	×	Н	L	Din	High-Z	Lower byte write
L	L	×	L	Н	High-Z	Din	Upper byte write
L	Н	Н	×	×	High-Z	High-Z	Output disable

Operation Table

Note: H: V_{IH} , L: V_{IL} , \times : V_{IH} or V_{IL}

Absolute Maximum Ratings

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Symbol	Value	Unit	DetaSha
V _{cc}	-0.5 to + 4.6	V	DataShe
V _T	-0.5^{*1} to V _{cc} + 0.3 ^{*2}	V	
DataSheet4U.com	1.0	W	
Tstg	-55 to +125	°C	
Tbias	-40 to +85	°C	
	V _{cc} V _T DataSheet4U.com Tstg	V_{cc} -0.5 to + 4.6 V_{T} -0.5 ^{*1} to V_{cc} + 0.3 ^{*2} Data Pr_T 1.0 Tstg -55 to +125	V _{cc} -0.5 to + 4.6 V V_{T} -0.5 ^{*1} to V_{cc} + 0.3 ^{*2} V Data Preet4U.com 1.0 W Tstg -55 to +125 °C

Notes: 1. V_{τ} min: -3.0 V for pulse half-width \leq 30 ns.

2. Maximum voltage is +4.6 V.

DC Operating Conditions

Parameter	Symbol	Min	Тур	Max	Unit	Note
Supply voltage	V _{cc}	2.7	3.0	3.6	V	
	V _{ss}	0	0	0	V	
Input high voltage	V _{IH}	2.2	—	V_{cc} + 0.3	V	
Input low voltage	V _{IL}	-0.3	—	0.6	V	1
Ambient temperature range	Та	-40	—	85	°C	

Note: 1. V_{IL} min: -3.0 V for pulse half-width \leq 30 ns.

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DC Characteristics

Parameter	Symbol	Min	Тур*	¹ Max	Unit	Test conditions	
Input leakage current	$ \mathbf{I}_{\sqcup} $	_	_	1	μΑ	Vin = V_{ss} to V_{cc}	
Output leakage current	I _{LO}	_	—	1	μA		
Operating current	I _{cc}	_	_	20	mA	$\label{eq:constraint} \begin{array}{l} \overline{\text{CS}} = \text{V}_{\text{IL}}, \text{Others} = \text{V}_{\text{IH}}/\text{V}_{\text{IL}}, \\ \text{I}_{\text{I/O}} = 0 \text{mA} \end{array}$	
Average operating current	I _{cc1}	_	16	30	mA		
	I _{CC2}	_	2	5	mA	$\begin{array}{l} Cycle \ time = 1 \ \mu s, \ duty = 100\%, \\ I_{I/O} = 0 \ mA, \ \overline{CS} \leq 0.2 \ V, \\ V_{IH} \geq V_{CC} - 0.2 \ V, \ V_{IL} \leq 0.2 \ V \end{array}$	
Standby current	I _{SB}	_	0.1	0.3	mA	$\overline{\text{CS}} = V_{\text{IH}}$	
Standby current	*2 SB1	_	0.5	25	μΑ	$\begin{array}{l} 0 \ V \leq Vin \\ (1) \ \overline{CS} \geq V_{cc} - 0.2 \ V \ or \\ (2) \ \overline{LB} = \overline{UB} \geq V_{cc} - 0.2 \ V, \\ \overline{CS} \leq 0.2 \ V \end{array}$	
.com	I _{SB1} * ³	_	0.5	10	μΑ	Dat	taSh
Output high voltage	V _{OH}	2.2	_	_	V	$I_{OH} = -1 \text{ mA}$	
Output low voltage	V _{ol} D	a ta Sh	ne et 4U	.00.41	V	$I_{OL} = 2 \text{ mA}$	

Notes: 1. Typical values are at V_{cc} = 3.0 V, Ta = +25°C and not guaranteed.

2. This characteristic is guaranteed only for L version.

3. This characteristic is guaranteed only for L-SL version.

Capacitance (Ta = $+25^{\circ}$ C, f = 1.0 MHz)

Parameter	Symbol	Min	Тур	Max	Unit	Test conditions	Note
Input capacitance	Cin	_	_	8	pF	Vin = 0 V	1
Input/output capacitance	C _{I/O}	_		10	pF	$V_{I/O} = 0 V$	1

Note: 1. This parameter is sampled and not 100% tested.

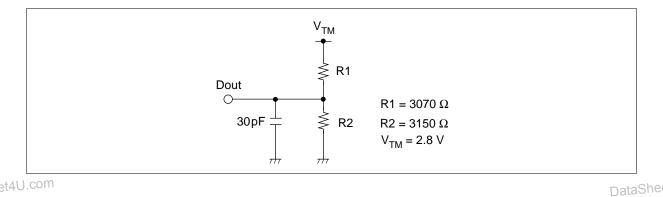
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AC Characteristics (Ta = -40 to $+85^{\circ}$ C, V_{CC} = 2.7 V to 3.6 V, unless otherwise noted.)

Test Conditions

- Input pulse levels: $V_{IL} = 0.4 \text{ V}, V_{IH} = 2.2 \text{ V}$
- Input rise and fall time: 5 ns
- Input and output timing reference levels: 1.5 V
- Output load: See figures (Including scope and jig)



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Read Cycle

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	HM62V	16514I			
	-5				
Symbol	Min	Max	Unit	Notes	
t _{RC}	55	_	ns		
t _{AA}		55	ns		
t _{ACS}	_	55	ns		
t _{oe}	_	35	ns		
t _{oH}	10	_	ns		
t _{BA}	_	55	ns		
t _{CLZ}	10	_	ns	2, 3	
t _{BLZ}	5	_	ns	2, 3	
t _{oLZ}	5		ns	2, 3	
t _{cHZ}	0	20	ns	1, 2, 3	
t _{BHZ}	0	20	ns	1, 2, 3	
t _{oHZ}	0	20	ns	1, 2, 3 Data	
	t _{RC} t _{AA} t _{ACS} t _{OE} t _{OH} t _{BA} t _{CLZ} t _{BLZ} t _{OLZ} t _{CHZ} t _{CHZ}	$\begin{tabular}{ c c c } \hline & & & & & & & & & & & & & & & & & & $	Symbol Min Max t_{RC} 55 — t_{AA} — 55 t_{ACS} — 55 t_{OE} — 35 t_{OE} — 35 t_{OH} 10 — t_{BA} — 55 t_{CLZ} 10 — t_{BLZ} 5 — t_{OLZ} 5 — t_{CHZ} 0 20 t_{BHZ} 0 20	Image: Figure 1 Image: Figure 1 -5 ns t_{RC} 55 ns t_{AA} 55 ns t_{ACS} 55 ns t_{OE} 35 ns t_{OE} 35 ns t_{OH} 10 ns t_{OH} 10 ns t_{OH} 10 ns t_{BA} 55 ns t_{BA} 55 ns ns t_{BLZ} 5 ns t_{OLZ} 5 ns t_{OLZ} 5 ns t_{OLZ} 0 20 ns	

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Write Cycle

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		HM62V	′16514I			
		-5				
Parameter	Symbol	Min	Max	Unit	Notes	
Write cycle time	t _{wc}	55		ns		
Address valid to end of write	t _{AW}	50		ns		
Chip selection to end of write	t _{cw}	50		ns	5	
Write pulse width	t _{wP}	40		ns	4	
$\overline{\text{LB}}$, $\overline{\text{UB}}$ valid to end of write	t _{BW}	50		ns		
Address setup time	t _{AS}	0		ns	6	
Write recovery time	t _{wR}	0		ns	7	
Data to write time overlap	t _{DW}	25		ns		
Data hold from write time	t _{DH}	0		ns		
Output active from end of write	t _{ow}	5		ns	2	
Output disable to output in High-Z	t _{oHz}	0	20	ns	1, 2	
Write to output in high-Z	t _{wHZ}	0	20	ns	1, 2	

Notes: 1. t_{CHZ}, t_{OHZ}, t_{WHZ} and t_{BHZ} are defined as the time at which the outputs achieve the open circuit conditions and are not referred to output voltage levels.

2. This parameter is sampled and not 100% tested.

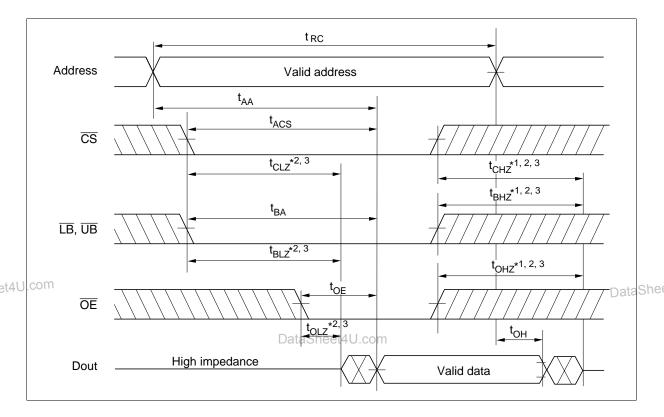
- At any given temperature and voltage condition, t_{Hz} max is less than t_{Lz} min both for a given device and from device to device.
- 4. A write occures during the overlap of a low CS, a low WE and a low LB or a low UB. A write begins at the latest transition among CS going low, WE going low and LB going low or UB going low. A write ends at the earliest transition among CS going high, WE going high and LB going high or UB going high. t_{WP} is measured from the beginning of write to the end of write.
- 5. t_{cw} is measured from the later of \overline{CS} going low to the end of write.
- 6. t_{AS} is measured from the address valid to the beginning of write.
- 7. t_{WR} is measured from the earliest of \overline{CS} or \overline{WE} going high to the end of write cycle.

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Timing Waveform

Read Cycle



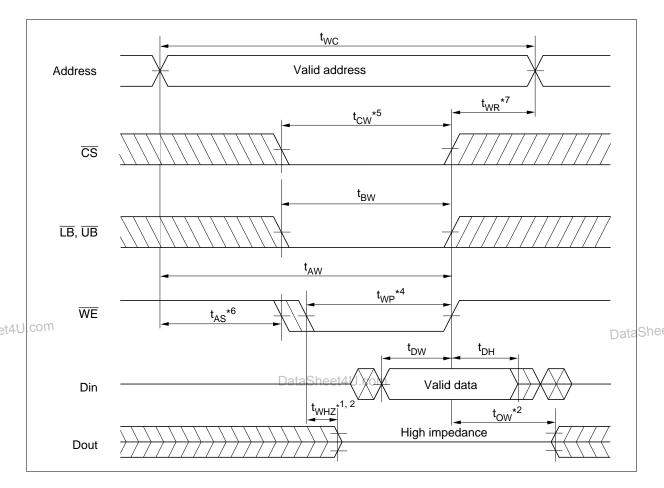
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Write Cycle (1) ($\overline{\text{WE}}$ Clock)

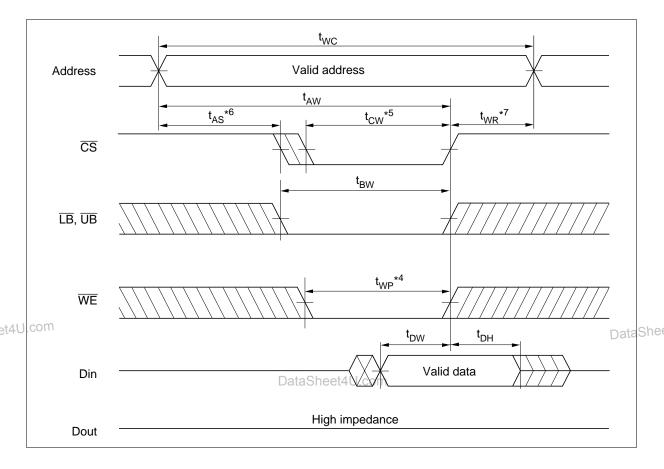


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Write Cycle (2) (\overline{CS} Clock, $\overline{OE} = V_{IH}$)



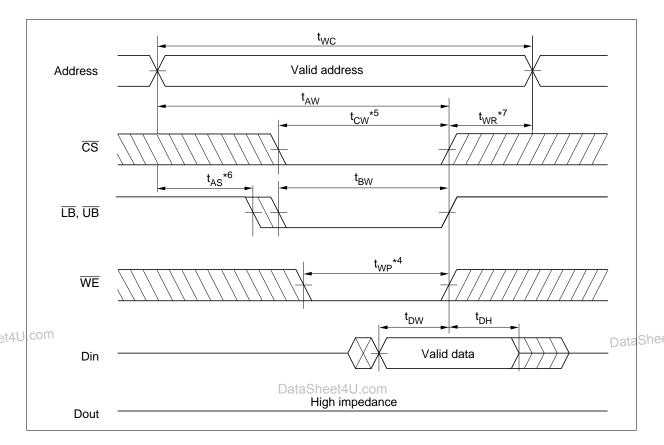
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Write Cycle (3) ($\overline{\text{LB}}$, $\overline{\text{UB}}$ Clock, $\overline{\text{OE}} = V_{\text{IH}}$)



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Low V_{CC} Data Retention Characteristics (Ta = -40 to $+85^{\circ}$ C)

Parameter	Symbol	Min	Typ*4	Max	Unit	Test conditions*3
V_{cc} for data retention	V_{DR}	2.0	_	3.6	V	$ \begin{array}{l} \text{Vin} \geq 0\text{V} \\ \text{(1)} \ \overline{\text{CS}} \geq \text{V}_{\text{CC}} - 0.2 \text{ V or} \\ \text{(2)} \ \overline{\text{LB}} = \overline{\text{UB}} \geq \text{V}_{\text{CC}} - 0.2 \text{ V} \\ \overline{\text{CS}} \leq 0.2 \text{ V} \end{array} $
Data retention current	I *1 CCDR	_	0.5	25	μΑ	$V_{cc} = 3.0 \text{ V}, \text{ Vin } \ge 0\text{V}$ (1) $\overline{CS} \ge V_{cc} - 0.2 \text{ V} \text{ or}$ (2) $\overline{LB} = \overline{UB} \ge V_{cc} - 0.2 \text{ V}$ $\overline{CS} \le 0.2 \text{ V}$
	I CCDR *2	_	0.5	10	μΑ	
Chip deselect to data retention time	\mathbf{t}_{CDR}	0	_	_	ns	See retention waveform
Operation recovery time	t _R	t _{RC} *5	_	—	ns	_

Notes: 1. This characteristic is guaranteed only for L version.

2. This characteristic is guaranteed only for L-SL version.

3. \overline{CS} controls address buffer, \overline{WE} buffer, \overline{OE} buffer, \overline{LB} , \overline{UB} buffer and Din buffer. If \overline{CS} controls data retention mode, Vin levels (address, \overline{WE} , \overline{OE} , \overline{LB} , \overline{UB} , \overline{IO}) can be in the high impedance state. If \overline{LB} , \overline{UB} controls data retention mode, \overline{LB} , \overline{UB} must be $\overline{LB} = \overline{UB} \ge V_{cc} - 0.2 \text{ V}$, \overline{CS} must be $\overline{CS} \le 0.2 \text{ V}$. The other input levels (address, \overline{WE} , \overline{OE} , \overline{IO} , \overline{IO}) can be in the high impedance state.

4. Typical values are at V_{cc} = 3.0 V, Ta = +25°C and not guaranteed.

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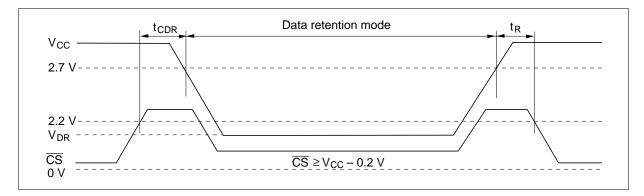
5. t_{RC} = read cycle time.

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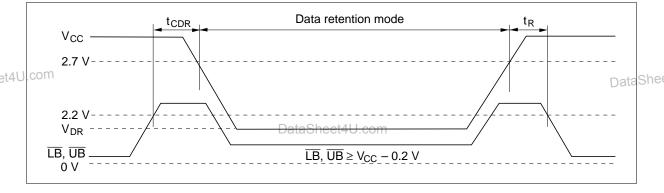
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Low V_{CC} Data Retention Timing Waveform (1) (\overline{CS} Controlled)





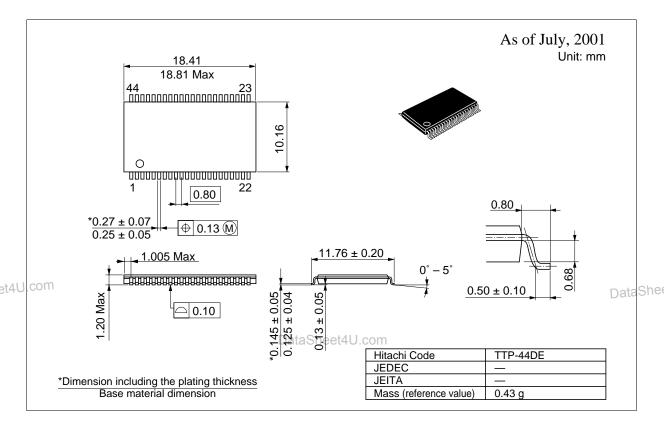


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Package Dimensions

HM62V16514LTTI Series (TTP-44DE)



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